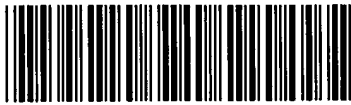


Search Notes

Application/Control No.

10/576,059

Examiner

Jennifer Y. Cho

Applicant(s)/Patent under
Reexamination

LANTZSCH ET AL.

Art Unit

1621

SEARCHED

Class	Subclass	Date	Examiner
560	170	2/2/2007	JC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search	2/2/2007	JC
STN Search	2/2/2007	KS
STN Search	1/29/2007	BS